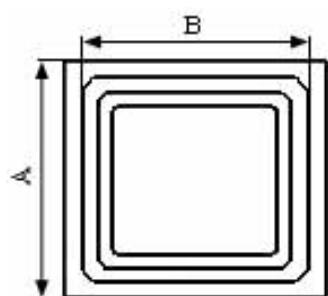


**SCHOTTKY DIODES KDN-03040A.**  
PRELIMINARY

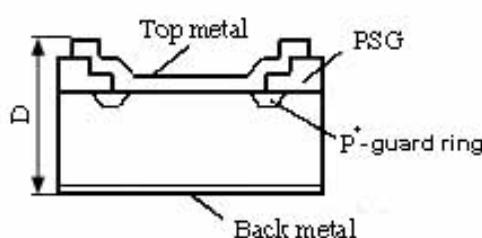


Rev.1. Feb. 2010

<b>VSP-MIKRON</b>		<b>3A/40V. Die Size-60mil.</b>		
<b>Electrical Characteristics</b>		<b>Symbol</b>	<b>Unit</b>	<b>Spec. limit</b>
Breakdown Voltage @ $I_R=10\text{mA}$		$V_{BR}$	V	40
Average Rectified Forward Current		$I_{F(AV)}$	A	3,0
DC Forward Voltage @ $25^\circ\text{C}$ , $I_F=3,0\text{A}$		$V_F$	V	0,50
Maximum Reverse Current  @ $25^\circ\text{C}$ , $V_R=45\text{V}$ $25^\circ\text{C}$ , $V_R=40\text{V}$ $125^\circ\text{C}$ , $V_R=40\text{V}$		$I_R$	mA	- 0,080 0,060 40,0
Peak Forward Surge Current 8,3ms single half sine-wave superimposed on rated load (JEDEC METHOD)		$I_{FSM}$	A	90
Peak Repetitive Reverse Surge Current @ $2,0\mu\text{s}$ , $f=1\text{kHz.}$ , $T_J<150^\circ\text{C.}$		$I_{RRM}$	A	2,5
Electrostatic Discharge Voltage. JEDEC Method. ESD HBM. Contact.		ESD	kV	$\pm 8$ (contact)
Voltage Rate of Change		$dV/dt$	V/ $\mu\text{S}$	10.000
Operating Junction Temperature		$T_J$	°C	150



DIM	ITEM	μm
$A_x$	Wafer Form Die Size	1520
$A_y$		1520
$B_x$	Top Metal Size	1380
$B_y$		1380
D	Thickness	300max.
	Scribe line Width	80



*Top metal:* a) **Al** – for Wire Bond;  
b) **Al-Ni-Ag** – for Soldering.  
*Backside metal:* **Ti-Ni-Ag**.